


<b>Search Notes</b>  	<b>Application/Control No.</b>  10718279	<b>Applicant(s)/Patent Under Reexamination</b>  SCOTT ET AL.
	<b>Examiner</b>  Dare, Ryan	<b>Art Unit</b>  2186

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST(US-PGPUB; USPAT, USOCR; EPO; JPO; DERWENT; IBM_TDB) text search and limited classification search of 711/103,102,173,129,5 and 365/185.33,189.04	11/22/05	RD
updated EAST search	8/4/06	RD
EIC NPL and foreign patent search	8/4/06	RD
EAST(US-PGPUB; USPAT, USOCR; EPO; JPO; DERWENT; IBM_TDB) text search and limited classification search of 711/103,102,173,129,5,2,202,165 and 365/185.33,189.04. See search history.	1/8/07	RD
Consulted Hong Kim, Primary Examiner class 711	1/8/07	RD
Consulted Kevin Verbrugge, Primary Examiner class 711	1/8/07	RD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
711	103, EAST text search of US PGPubs	1/7/07	RD